

Aberration Control Method of Parasitic Force for Ultra-Low Aberration Lithography Lens

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Introduction

- Projection lithography objective lens has to use more adjusting mechanism units for image quality compensation facing higher lithography nodes.
- The mechanism will induce aberration and distortion during working due to the parasitic force.
- The generation mechanism and suppression method of the parasitic force in the adjusting mechanism are studied and optimized to meet the requirements of ultra-low aberration of leading-edge microlithography.

Cause

- Driving force from Mechanism
- Unreasonable Stiffness Design
- Lack of Stress Isolation Design
- Superimposed Effect

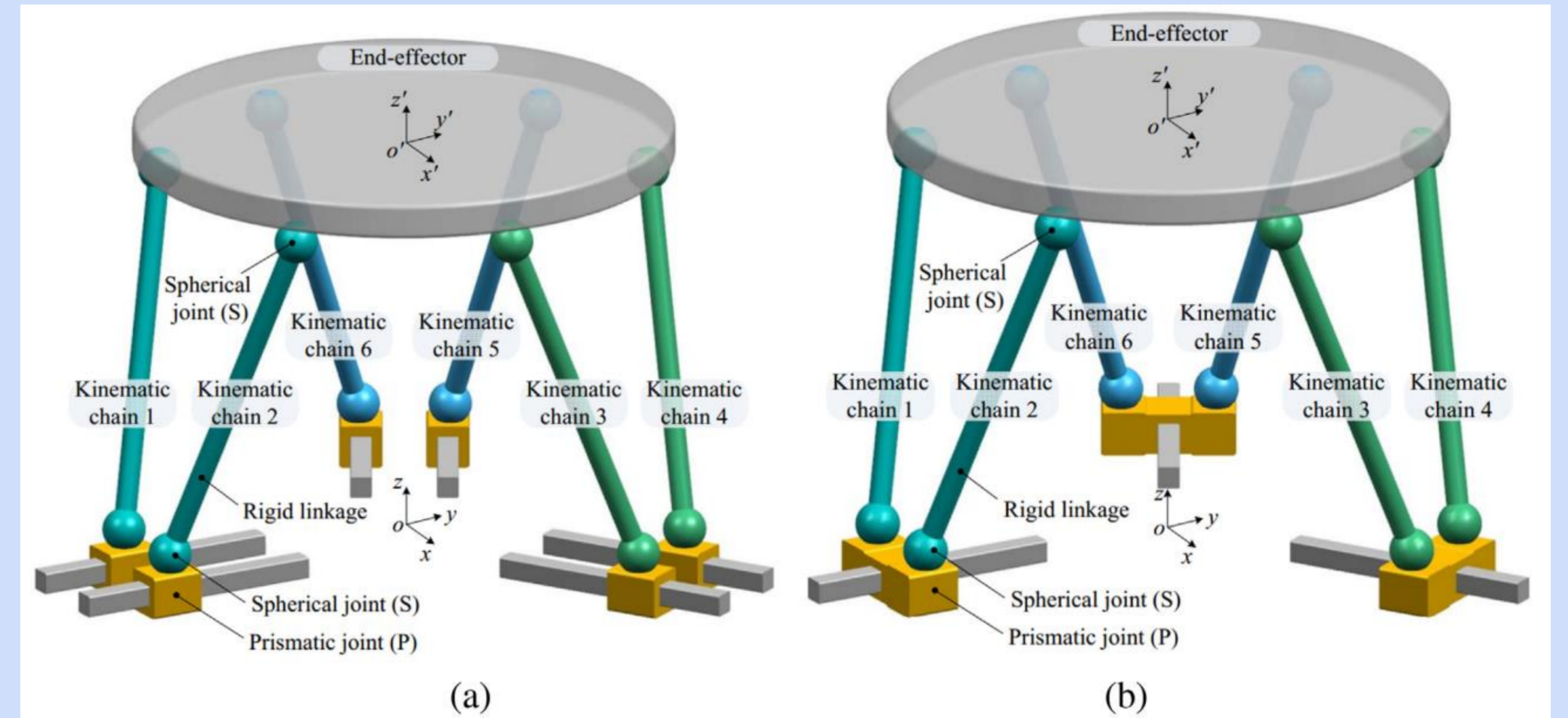
Action

- Actuation Decoupling
- Stiffness Optimization
- Mechanism clocking

Methods used to control aberration from parasitic force

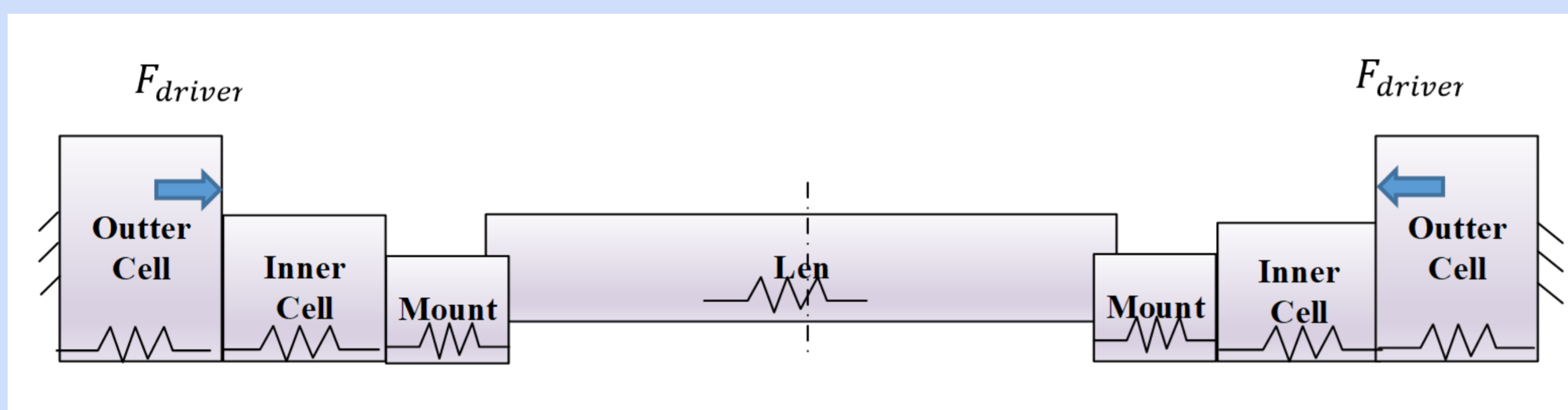
Kinematic Constraint Coupling Design

- An ultimate way to prevent deforming the lens from the parasitic force is kinematic coupling connection design.
- We use this design between outer cell and inner cell connection in the mechanism to avoid deformation during working.
- The mechanism coupling force can also be canceled through reasonable kinematic constraint.

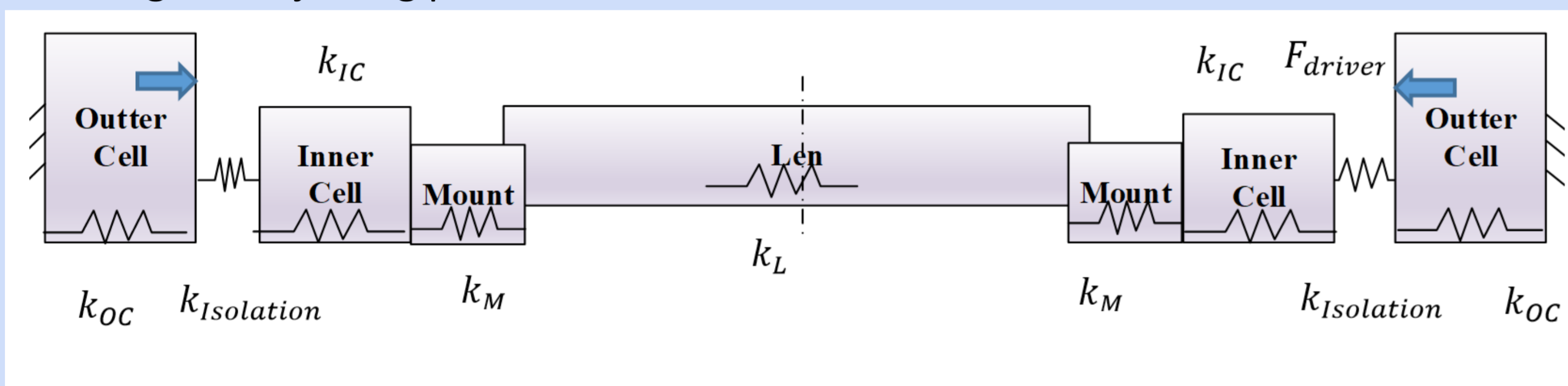


Two kinematic constraint configurations

Structure of mechanism Optimization

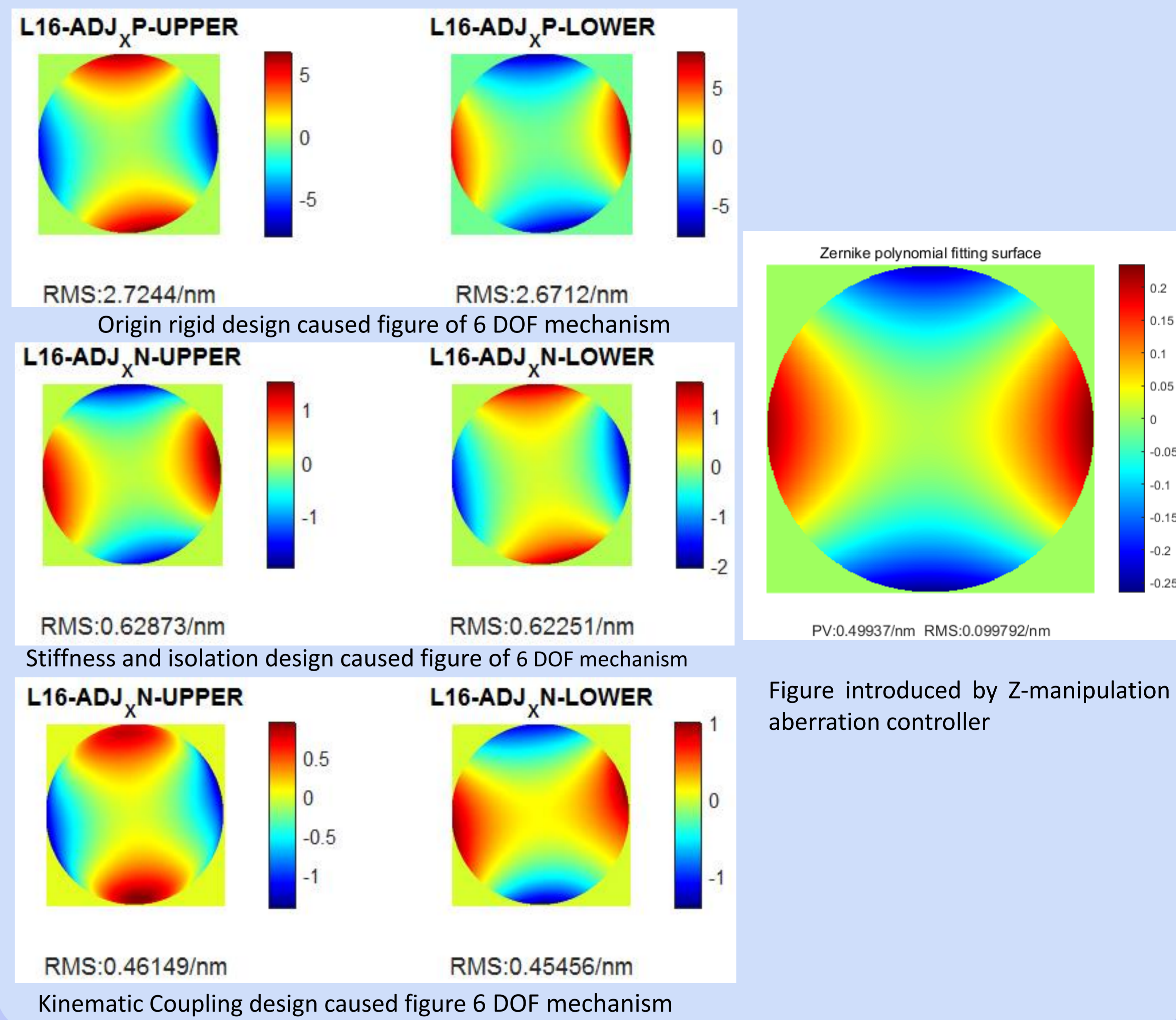


- Adjusting mechanism units in lithography objective lens can driver the lens in multi DOF direction.
- In the previous design, driver force will deform the lens directly due the stiffness during the adjusting process.

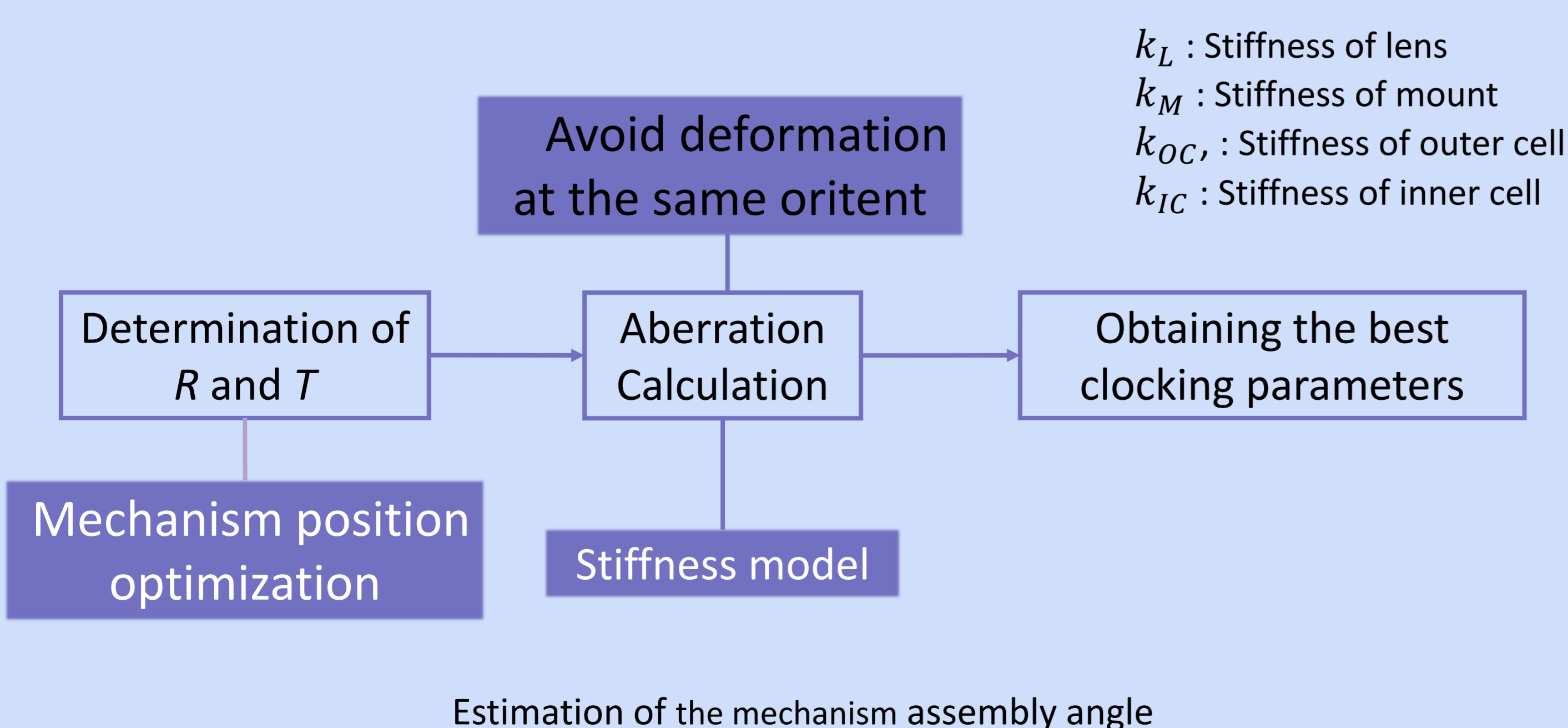
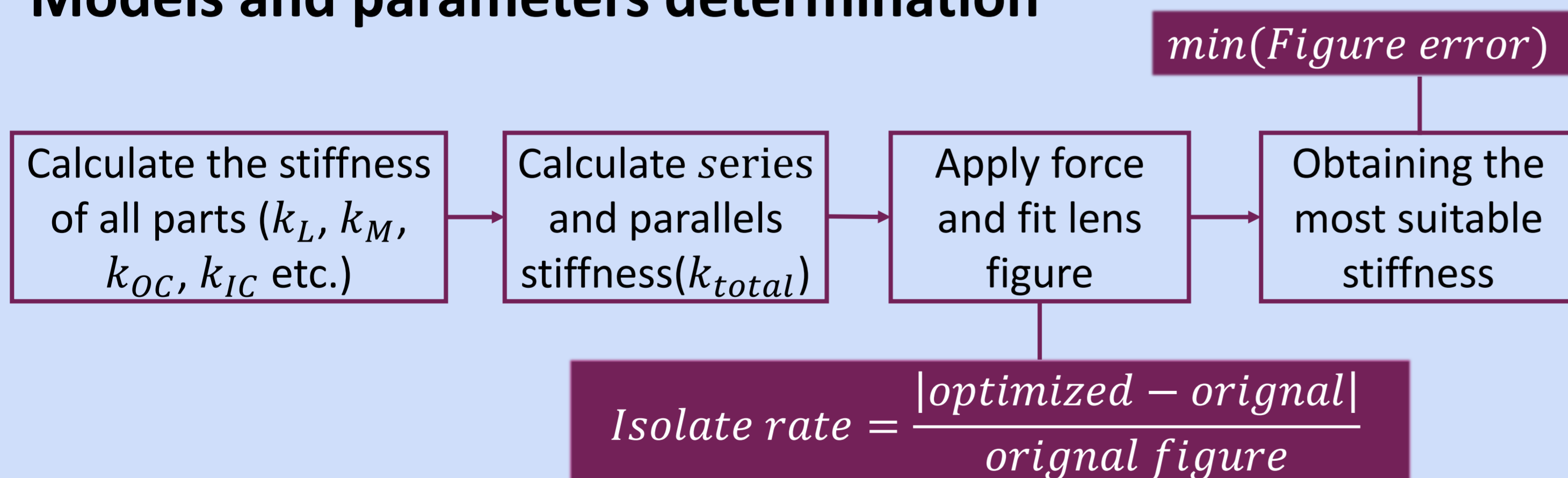


- After optimization design, there is a Stress Isolation Design ($k_{Isolation}$ is added).
- Driver force will not deform the lens directly because the force is decreased through the SID.
- Stress Isolation Design is achieved through stiffness design of the cell, mount and mechanism flexure.

Results



Models and parameters determination



Conclusions

- The biggest source of the parasitic force is unreasonable stiffness design.
- Mechanism stiffness optimization can be used to reduce the deformation induced by the parasitic force.
- Kinematic constraint design is also a good choice to avoid deforming lens.
- Through the reasonable clocking between the mechanisms, the wavefront aberration caused by parasitic force will not overlying.
- The figure of lens induced by the parasitic force in the Z-manipulation aberration controller is less than 0.1nm RMS and the ultra-low aberration is achieved for the leading-edge lithographic projection objective

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